## Application/Control No. 10/001,755 Applicant(s)/Patent Under Reexamination TAYLOR ET AL. Examiner Christopher H Yaen Applicant(s)/Patent Under Reexamination TAYLOR ET AL. Page 1 of 1

## U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
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## NON-PATENT DOCUMENTS

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